Issue Classification								

Application/Control No.	Applicant(s)/Patent under Reexamination						
09/842,404	STRUBLE, CHESTER						
Examiner	Art Unit						

3766

					ISS	SUE C	LASSI	ICATIO	ON				
ORIGINAL				INAL		CROSS REFERENCE(S)							
CLASS SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
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I	NTEF	RNAT	IONAL	CLASSIFICATION			1						
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JAONES P. OLOPEZA (Assistant Examiner) (Date) (Legal Instruments Examiner) (D				SUPU. PATENT EXAMINER ART UNIT 3766 (Primary Examiner) (Dalg)				O.G. O.G. Print Claim(s)					

Frances P. Oropeza

Claims renumbered in the same order as presented by applicant						□СРА		T.D.		☐ R.1.47	
Final	Final	Final	Final	Original	Final	Original	Final	Original	Final	Original	
X	3/	261		9/1		121		151		181	
	3/2	3 62		91		12/2		152		182	
8	3/2 3/3	63		9 3		128		153		183	
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8	3A 25	68		2 5	11:	125		155		185	
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72 73 74 75	#2	7/2		102	18	132		162		192	
13	A 3	7/3		103		133		163		193	
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15	13/5	7,8		1,015		135		165		195	
180	46	7,8		106		136		166		196	
77	47	77		107		137		167		197	
18	4/8	7/8		1,08		138		168		198	
79	19/9	7,8		109		139		169		199	
28	50	78 78 78 78 78 78 78 90		1/10		140		170		200	
21	5/	81		1/9		141		171		201	
22	52 \$3,	82		112		142		172		202	
23	5 3,	3/3		1/13		143		173		203	
24	5/4	5 . 84		124		144		174		204	
2A 25 26 21	54 55 56 51	6 85		1/15		145		175		205	
26	56	7_ 86				146		176		206	
27	5/1	8 87		116 117		147		177		207	
28	58 59	9. 88		1/18		148		178		208	
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